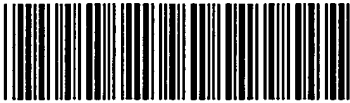


**Search Notes**

Application/Control No.

10/710,484

Examiner

Ahshik Kim

Applicant(s)/Patent under  
Reexamination

BISHOP ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	379	5/27/2005	AK
	380		
	382		
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705	35		
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	68		
	70		
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**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed parent application 10/242,584	5/27/2005	AK